

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination KAYAMA ET AL.	
			Examiner Xiuyu Tai	Art Unit 1795	Page 1 of 1

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	C	US-			
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	J	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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